## Notice of References Cited Application/Control No. 10/567,513 Applicant(s)/Patent Under Reexamination CASPERSON ET AL. Examiner Quang N. Nguyen Applicant(s)/Patent Under Reexamination CASPERSON ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date . MM-YYYY	Name	Classification
*	Α	US-2003/0219104	11-2003	Malik, Dale W.	709/206
*	В	US-2004/0103153	05-2004	Chang et al.	709/206
*	C	US-2002/0021465	02-2002	Moore et al.	359/125
*	D	US-2002/0078259	06-2002	Wendorf et al.	709/328
*	Е	US-2002/0163534	11-2002	Choi et al.	709/208
*	F	US-2004/0139210	07-2004	Lee et al.	709/230
*	G	US-2005/0101312	05-2005	Kang, Sung Hwan	455/422.1
*	Н	US-6,526,581	02-2003	Edson, Richard	725/74
*	ı	US-6,680,730	01-2004	Shields et al.	709/217
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					•
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	<b>v</b>	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.